S/N: TBA

1/22/2002

DOCKET NO.: KAW-269-USAP

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of: Zongtao GE

Serial No.: TO BE ASSIGNED

Art Unit: TO BE ASSIGNED

Filed: January 22, 2001

Examiner: TO BE ASSIGNED

For: Phase Shift Fringe Analysis Method and Apparatus Using the

Same

# **APPLICATION DATA SHEET**

## (1) APPLICANT INFORMATION

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# (3) APPLICATION INFORMATION

Title

Phase Shift Fringe Analysis Method and

Apparatus Using the Same

Total # Draw Sheets

Suggested Figure for

<u>Publication</u>

Atty Docket Number

KAW-269-USAP

Type of Application

Utility

# (4) REPRESENTATIVE INFORMATION

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## (5) DOMESTIC PRIORITY INFORMATION

None

#### (6) FOREIGN PRIORITY INFORMATION

Application Number

2001-23200

Country

Japan

Filing Date

January 31, 2001

Application Number

2001-399179

Country

Japan

Filing Date

December 28, 2001

#### (7) ASSIGNEE INFORMATION

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